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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,070	VAN DER FELT	Z ET AL.
Examiner	Art Unit	
Peter B. Kim	2851	

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INTERFERENCE SEARCHED			
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST Searched (all databases) (see print out)	10/26/2005	PK